

20

(IEC 62326-20:2016, IDT)



**80**326 —2019

1 91 420 « 27 2019 . 800-62326-20—2016 20. » (IEC 82320616 «Printed boards Part 20: Electronic circuit boards for high-brightness LEDs», IDT). IEC/TC 91 5 26 29 2015 . Nt 162-*»*. (www.gost.ru)

II

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3.1		2
3.2		2
4	LEDs	2
5		3
5.1		3
5.2		6
5.3		7
5.4		9
5.5		10
5.6		11
5.7		14
5.8	<del>-</del>	14
6		14
6.1	14	
6.2		15
6.3		15
6.4		16
6.5		16
6.6		18
6.7		21
6.8		21
6.9	CSP	22
6.10	{	22
7		24
7.1		24
7.2		25
7.3		25
8	,	28
8.1		28
8.2		28
8.3		28
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**— 2020—06—01** 

20

Printed boards. Part 20. Electronic circuit boards for high-brightness LEDs

1 ) 2 IEC 60194. Printed board design, manufacture and assembly — Terms and definitions ( IEC 61169-3:2007. Test methods for electrical materials, printed boards and other interconnection structures and assemblies - Part 3: Test methods for interconnection structures (printed boards) ( IEC 61249-2-6. Materials for printed boards and other interconnecting structures — Part 8: forced base materials, clad and unclad — Brominated epoxide non-woven/woven E-glass reinforced laminated sheets of defined flammability (vertical burning test), copper-dad ( 2-6. ( ). Materials for printed boards and other interconnecting structures — Part 2-7: Reinforced IEC 61249-2 base materials dad and undad — Epoxide woven E-glass laminated sheet of defined flammability (vertical burning test), copper-clad ( ] IEC 62678-1-1. Device embedded substrate — Part 1-1: Generic specification — Test methods ( 1-1.

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62326*20-2019
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3 3.1 60194. 3.2 AABUS — BGA —  $\operatorname{CCL} -$ CSP — HDI — HID — LED — PWB — 4 **LEDs** PWB. - AABUS) ( 1 —

-		-				( 2( )
( -)		{		( )	.( 2 )	( - <sup>2</sup> / )
	-	I		1	10	-
		II				-
			1000			
		III				
			1000			
	-	I		1	10	-
		II				-
			1000			-
		III				
			1000			
		I		1	10	
	-	II				
	-		1000			
		III				
			1000			

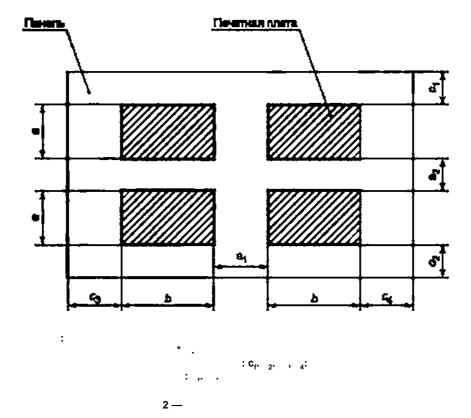
Тепловое излучение	_	A	,		B				C	
Классификация по основным матаривлам	MSK &	FRE TWIS \$0249-2 80249-3 -3, FR-4	-6 2-7	(G T) (QBR)	інея осно имэры ми экорными эрстинми)					*
•	Diska	A JUNATE		C	изное вени Вомозые пронурающ			C MOT	CHORRIA BUTUT NEVE	CKMM
									CHCIESHI RSG MET	
			ļ.			_				
Классификация по почитым платам	Ţ	Обычн	ra liotit	м кегід вомехе Діко	фациона д онтвома во		****	KOM NO	НАНТОВ	
•	1 -			Lichth	CENTRAL PARTY	neanynt	DESCK	никав	ого вор	пуск
					OUTOWER	The ed	MCTA	UND HE	runare	
Класомфикация по жинечным продуктам	TUTER BICETON		O)CIHE		i, fautoren: Iampei	ай		_		
		BILLÉRH MAR			а люмина Ной ланить					
-1				Замене лемпы неколивания Замене уличного фонеря						
			,							
			1		<del></del>		بسبين	₩		
			;		<del></del>	<del></del> -	<b> </b> -	3eun	на HID	ламп

1 —

5

5.1

5.1.1



2—

CCL				
CCL	4	6		9
1100000	55000	35080	2500	33333
********	577700	363080	*******	222 - 400
*100000	<del>5</del> 30000	<b>#5000</b>	350000	333 » 400

S.1.2

3.

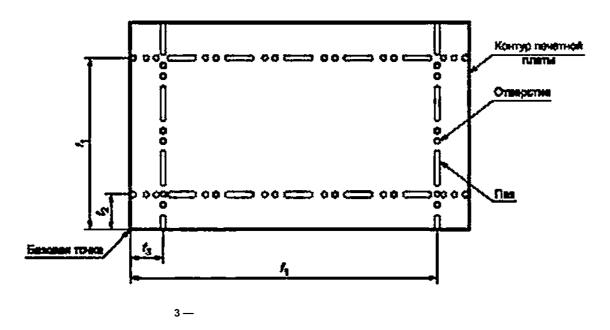
3 —

,			
100	± 0.2		
100	0.1	50 .	100

5.1.3

3.

4.



4 —

100	1 0.2		
100	0.1	50 .	100

5.1.4 VV- ( ) 4 5. V- ( . , 4) 5. V- ( ) ( ) -

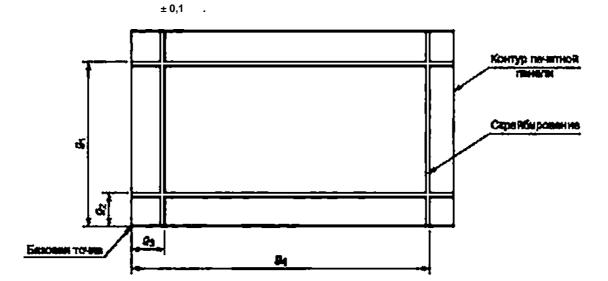
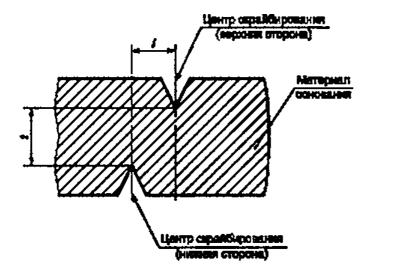


Рисунок 4 — Расстояние от базовой точки до скрайбирования



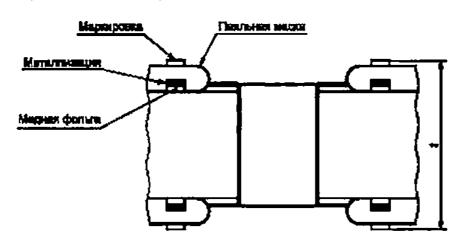
5 —

,			
100	± 0.2		
100	0.1	50 .	100

**5** —

5.2

6. 6.



6 — .

Таблица 6 — Общая толщина и ее допустимое отклонение

{	)<	
0.3 0.5		+ 0.10 -0.05
0.5 0.8		±0.10
0.8 1.10		±0.15
1.10 1.40		±0.17
1.40 20		±0.19
2,00		±10%

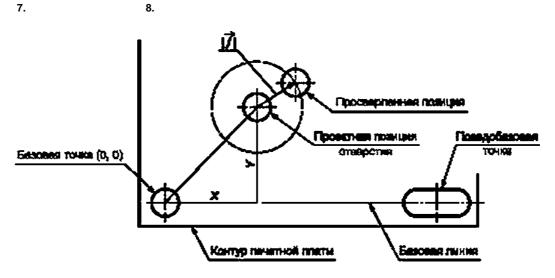
AABUS.

7—

)

f		
	0.6 2.0	±0.10
	2.0	±0.15
		±0.10

(( j )) ,

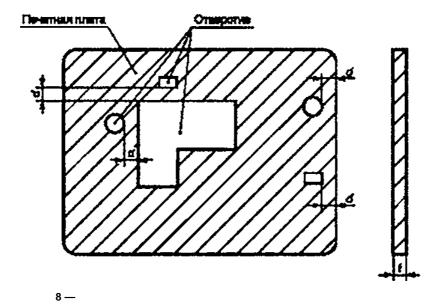


7 —

8 —

,			
400.	0.1		
400.	0.05	100 .	400

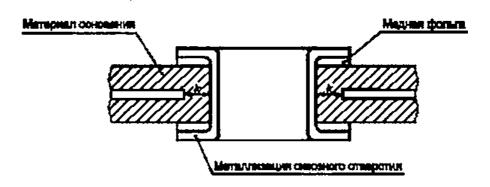
) (d) 8. (d) 1.0 . ·



9 —

		0	
			(d)
>	1.0 .	,	(/)
	1.5 .	,	()

d) ( ). 9. 0.325 10. 0.325

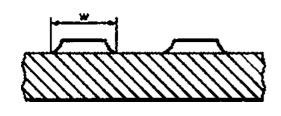


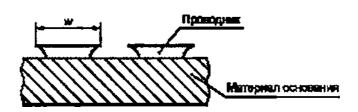
9 —

10 —

		{ ),
HDI	0.5	0.05
	0.3	0.25
	0.5	0.3
	0.35	0.3

	5.3.2							10.05		* 0.10	— 0,00	) . ;	8	-
	5.3.3			(	(			)						
	a)				•	•		± 0,1	10 .					
	b)							_ 0,			8.			
5.3.1	c)		).											
		2.0					AABUS.				2.0	•		-
1.	d) 0 .													-
	5.4													
	5.4.1								(w),				1	10.
					,			11.	•					-





AABUS.

10 —

11 —

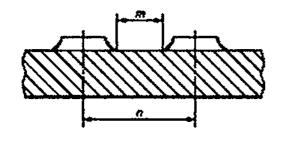
()		
50 75	±25	15 20
75 100	±30	20 40
100 300	±50	30 50
300	± 100	40 70
	± 150	70
	±200	105
	±300	140
		•

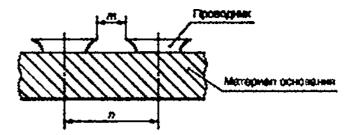
5.4.2

11.

0) , 12.

AABUS.





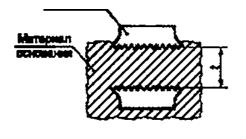
.

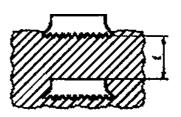
11 —

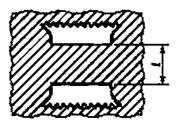
12 —

(ft)		
50 75	±25	15 20
75 100	±30	20 40
100 300	±50	30 50
300	± 100	40 70

5.4.3 (0 12.







.

12 —

5.5

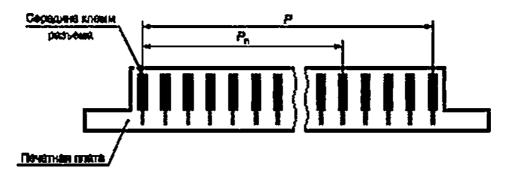
5.5.1

13. 0.10 . 0,01 ( ) 100 .

( . ). 20 .

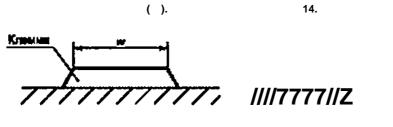
13.

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13 —

5.5.2



14 —

13 —

5.5.3

W	
1.0	±0.05
1.0	±0.10



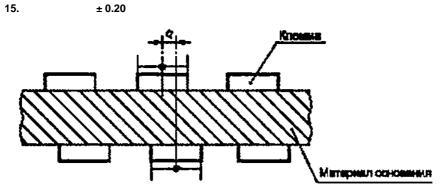


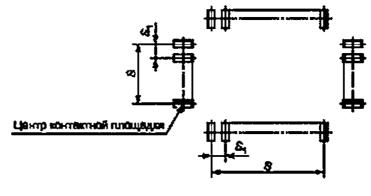
Рисунок 15 — Смещение середины клемм на верхней и нижней стороне платы

5.6

5.6.1

(S). 16.

(S,) 14.

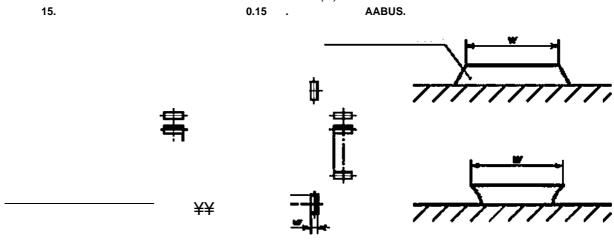


16 —

14 —

	,
S,	±0.03
s	±0.05

5.6.2 (*w*). 17.



17 —

15 —

	*	
0.15 0.35		±0.04
0.35		±0.06

5.6.3

CSP

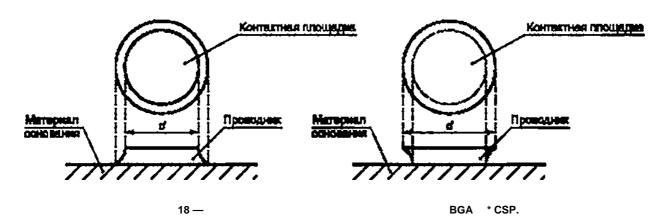
BGA CSP

BGA CSP

BGA CSP

18. (d)

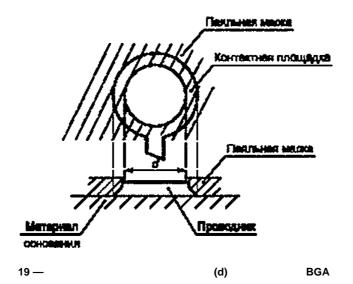
CSP, , 16.



16 — BGA CSP

	,	,
HD1	+ 0.02	20 30
no!	-0.03	20 30
	+ 0.03	20 50
	-0.05	30 50

) 19. (d) BGA CSP. ,



17 — (d) BGA CSP

	,
HDI	±0.03
	±0.05

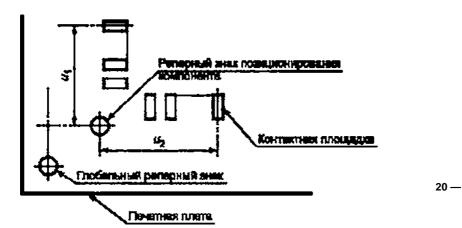
CSP,

62326\*20-2019

5.7

5.7.1

20 18.



18 —

	1.0
	,

5.7.2

.

, 20. ± 0,1 .

5.7.3 ( ,, <sub>2</sub>), -

20, ± 0,05 .

5.8 —

19.

19 —

	( ),	,
2.4		AABUS
1.0	2.4	15
0.5	1.0	12
0.5		10

6

6.1

0.13 .

6.2

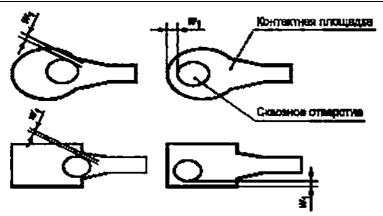
5.5.3, 6.1 6.3.

-(w<sub>2</sub>)

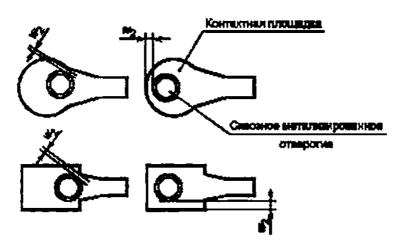
, 20 ( . 21).

20 —

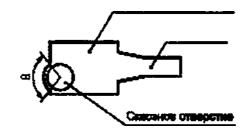
	4*				
		2 0.03			
		OS 90			
,		2 0.05			
		w <sub>2</sub> 0.03			
(	)4)	0 S 90			
	(	( ) <sup>4</sup> )			



Рисунох 21 а — Минимальный поясок на внешнем слое



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21 — 21 —

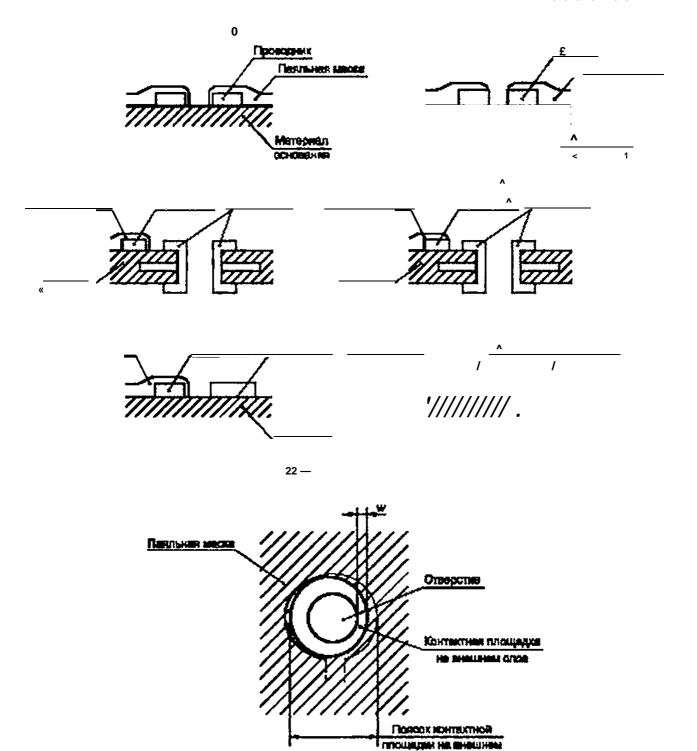
6.4
6.4.1
...
a)
2.0
...
b)

0.1 .
6.4.2 , , , ).

6.5

a) BGA CSP 5.6.3; b) , , ; c) , 22. d) , (w)

, , 23. , , 21.

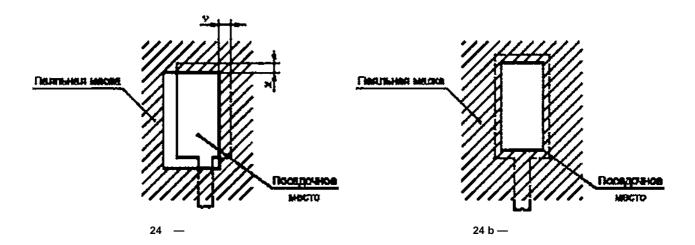


23 — ,

21 —

«
0.03
70 %

AABUS.



24 — ,

**22** — ,

	,
()	0.05
()	0.05

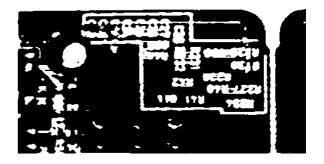
f) , , -

6.6

6.6.1

) 25.

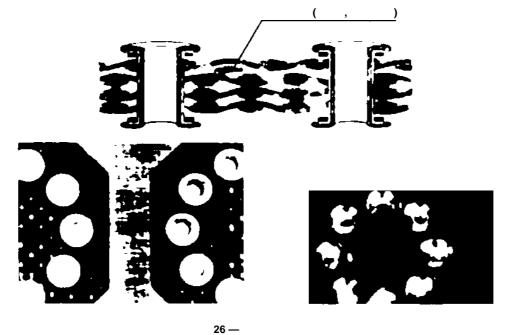




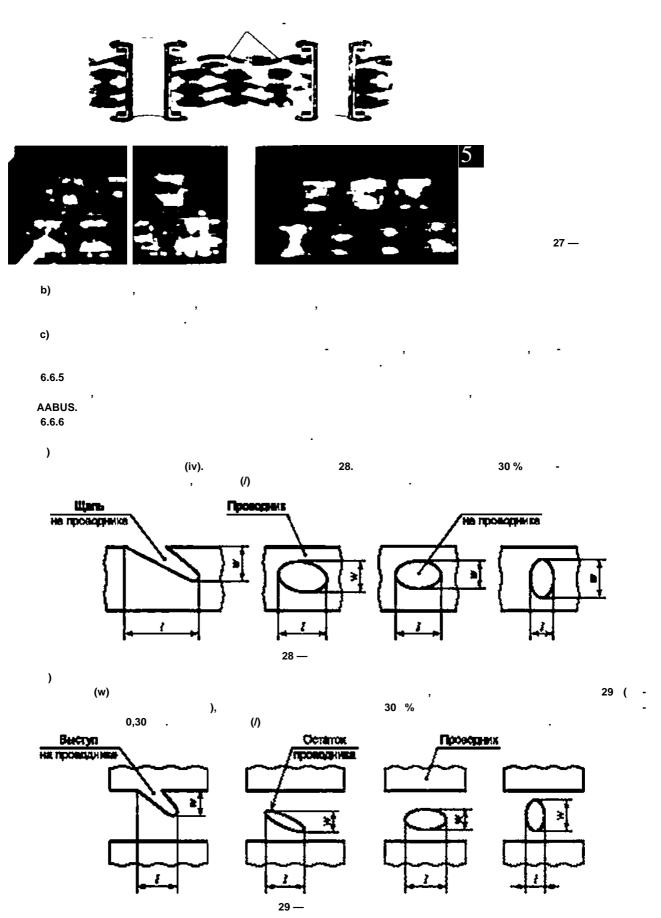
25 —

# AZI3

26 27.

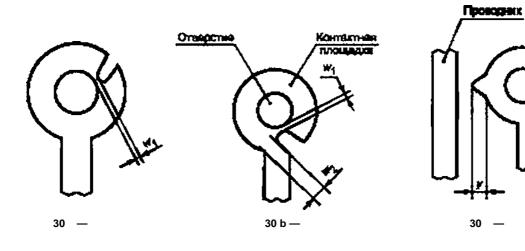


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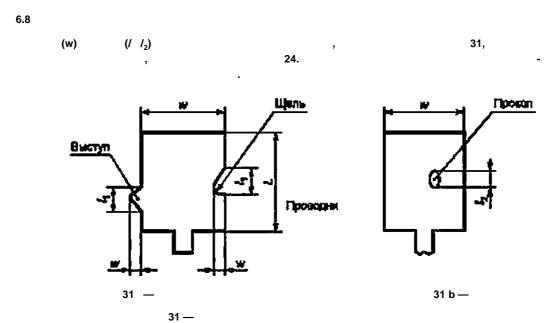


23 — ,

		,
	-	20 %
, -	'1	
	w2	70 %
		8 6.6.6 )— w



30 —

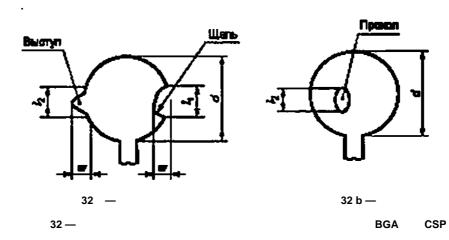


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24 —

		0,6	0.3
	w	20 % w	0,15
	/ <sub>1</sub>	5	0 % L
(	/?)	20 % w	0,15
			-
	5.4.2.		

6.9 BGA CSP 8GA CSP. 32,

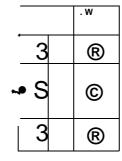


25 — CSP

		BGA
		80 %
(	/ <sub>2</sub> )	
		( . 5.4.2).

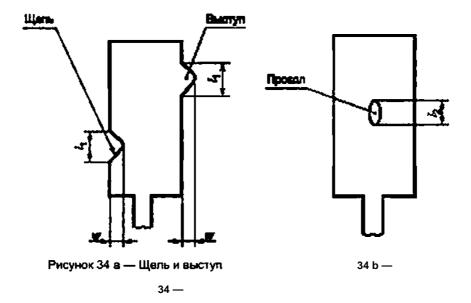
6.10 ( ) ( . 33),

, 34. . 26.



1 1

33 —



26— 8

				1	»	
-						
(Ni)		,				
-						
				1		
	0.2		-			0.5 -
			0.1			0.5
			0.1	I		
- 34. <i>I<sub>v</sub> w</i>	/ <sub>1</sub> 0.1 0.1 0.1	L w		I,	0.2 <i>L</i>	0.2 W
		,	1,0 <i>L</i> 0.2	iy	0,3	2.0 L w -
	( . 5.4.2	)				-
( - / <sub>2</sub> ) . 34				0.05	0.10	10 %
				/2 0.10	0.20	2 %
				/2 0.20		-
			,	•	1	

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7

7.1

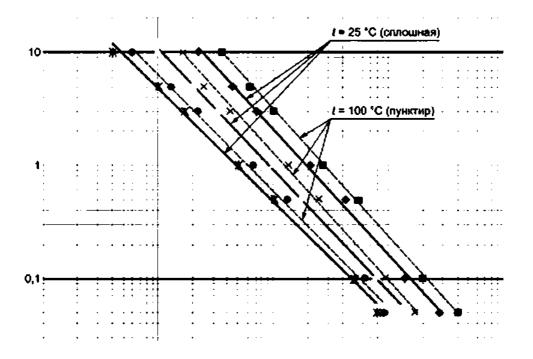
27.

35.

27 —

	AABUS.	_	10.12 61189-3(2007)
	, 35	i	10.13 61189-3(2007)

100



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= 1.8 • 10"® • .

35 — ,

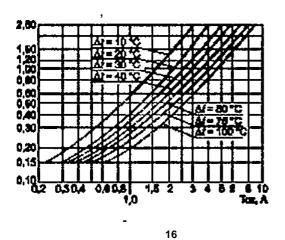
7.2

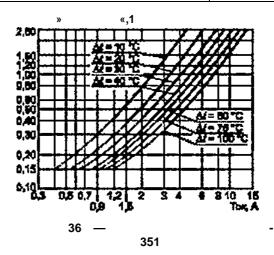
28.

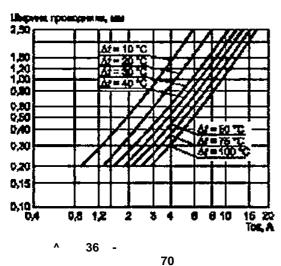
36.

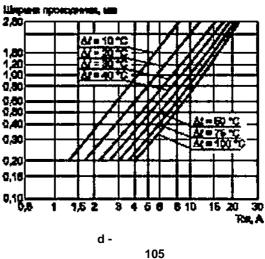
28 —

	AABUS	
-	, 36	62878-1-1
	30	





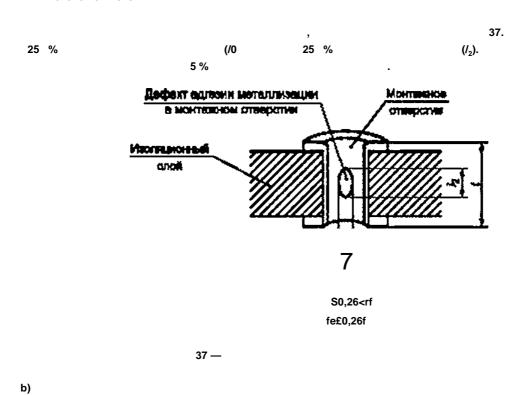


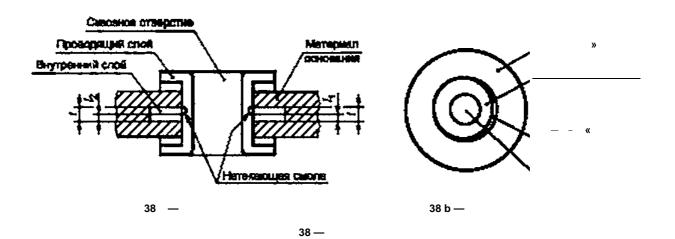


36 —

7.3 7.3.1

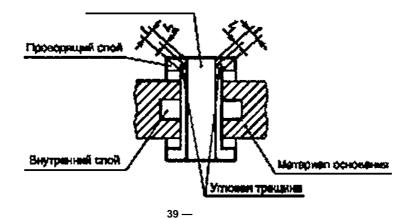
(d)





29 —

HDI	10 %
	25 %



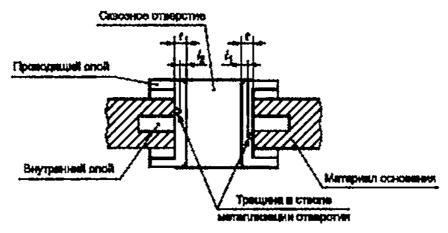
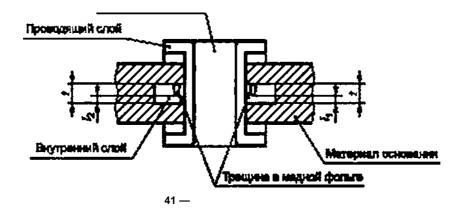


Рисунок 40 — Трещина ствола



8		,						
8.1								
			AABUS	<b>S</b> .				:
a)		1		:				
b)		;						
c)	•							
8.2								
			AABUS.				:	
a)		1		:				
b)			;					
c)	;							
d)		•						
8.3								
8.3.1								
					,	,	-	
8.3.2								
			:	,			, -	
	•							

( )

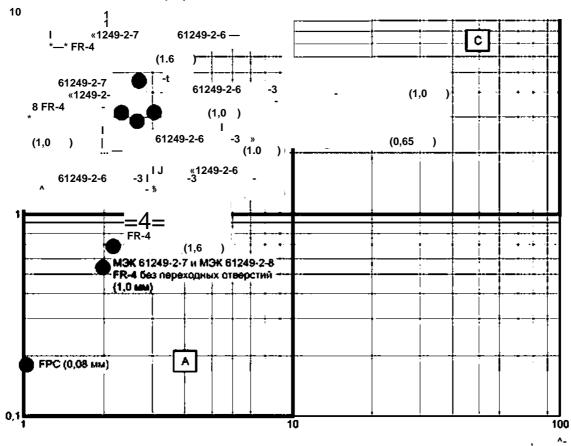
a)
1 / ;
b)
1 / .

( /^).

c)
10 / ²;
d)

, 10 / ².

.1 .1



.1 —

.1 —

			( / 2 )
		10	10
	1		_
( / )	1		

.2

.2 —

.2 —							
					-	61169-2	
	-			2.	-		
						04400.0	
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				3.	-		
		(	)				
					-	60068-1	
	. 1.					04400.4	
					-	61189-1	
			•	1.	-		
							291
-	61196-3						
	61169-3						
							6906
							3599
							3611
	_						
						<del>_</del>	-
							8512-1
							8512-2
						_	_
	61189-3						<del></del>
	61189-3					12	
,	61189-3					15	
	61189-3					3E09.3E10	
	61169-3					09. 10	

	61189-3	09. 10	
	61189-3		
		05	
	61189-3	01	
	61189-3	02	
	61189-3		
	61189-3	01 -	
	61189-3	07	
	61189-3		
-	61189-3	07	
	61189-3	01	
	61189-3	01	_
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			29863
			29864
-	61189-3	01	
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		61189-3	_
			29862
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	,		9180
			3366 21948
	61189-3		
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60068-2-1	60068-2-1
61189-3	3N01 3N05
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